Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination LAI ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,238,757	12-1980	Schenck, John F.	257/253
*	В	US-5,066,582	11-1991	Tsuruta et al.	435/7.1
*	O	US-5,309,085	05-1994	Sohn, Byung Ki	257/253
*	D	US-6,482,639	11-2002	Snow et al.	435/287.2
*	Е	US-6,627,154	09-2003	Goodman et al.	422/82.01
*	F	US-6,716,642	04-2004	Wu et al.	436/518
*	G	US-2004/0262636	12-2004	Yang et al.	257/200
*	Ξ	US-2005/0053524	03-2005	Keersmaecker et al.	422/088
*	l	US-2005/0056828	03-2005	Wada et al.	257/040
	J	US-			
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
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	Т	_				

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	W	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.